

Notice of References Cited	Application/Control No. 10/064,252	Applicant(s)/Patent Under Reexamination YEH, CHIEN-LIANG	
	Examiner Cheukfan Lee	Art Unit 2625	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,687,024	02-2004	Short et al.	358/474
*	B	US-5,652,665	07-1997	Chen et al.	358/487
	C	US-			
	D	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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